

# N-Channel Enhancement Mode Power MOSFET

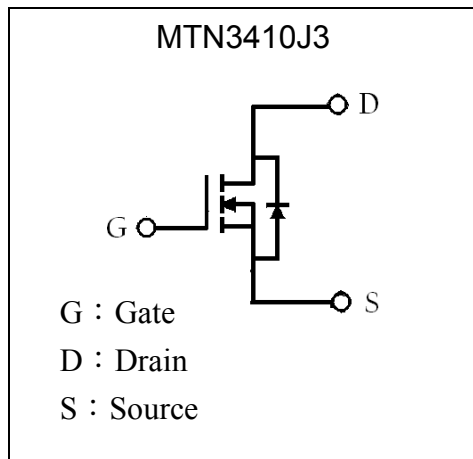
## MTN3410J3

$BV_{DSS}$	100V
$I_D$	50A
$R_{DS(ON)}$	30m $\Omega$

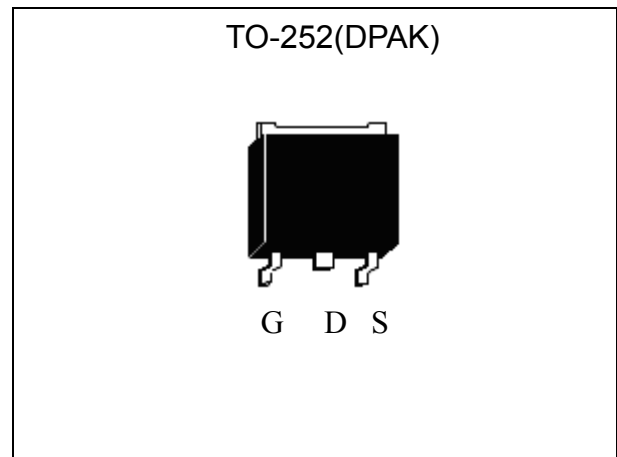
### Features

- Low Gate Charge
- Simple Drive Requirement
- Repetitive Avalanche Rated
- Fast Switching Characteristic
- RoHS compliant package

### Symbol

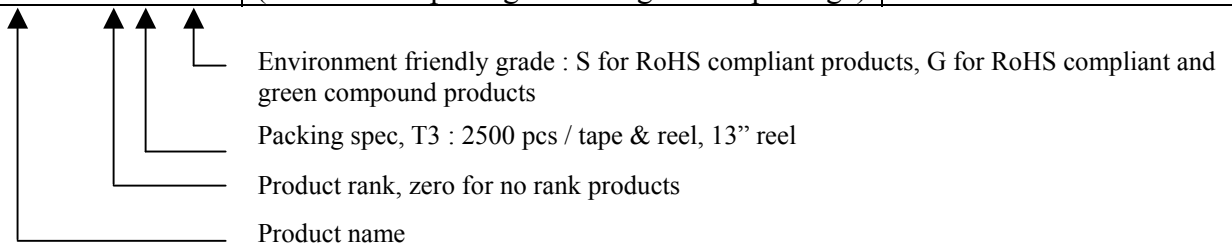


### Outline



### Ordering Information

Device	Package	Shipping
MTN3410J3-0-T3-G	TO-252 (Pb-free lead plating and halogen-free package)	2500 pcs / Tape & Reel





**Absolute Maximum Ratings** (T<sub>c</sub>=25°C, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V <sub>DS</sub>	100	V
Gate-Source Voltage	V <sub>GS</sub>	±30	
Continuous Drain Current @V <sub>GS</sub> =10V, T <sub>c</sub> =25°C	I <sub>D</sub>	50	A
Continuous Drain Current @V <sub>GS</sub> =10V, T <sub>c</sub> =100°C	I <sub>D</sub>	35	
Pulsed Drain Current (Note 1)	I <sub>DM</sub>	150	
Avalanche Current	I <sub>AS</sub>	30	
Avalanche Energy @ L=0.1mH, I <sub>D</sub> =30A, R <sub>G</sub> =25Ω	E <sub>AS</sub>	45	mJ
Repetitive Avalanche Energy@ L=0.05mH (Note 2)	E <sub>AR</sub>	22.5	
Total Power Dissipation (T <sub>c</sub> =25°C)	P <sub>d</sub>	60	W
Linear Derating Factor		0.37	W/°C
Operating Junction and Storage Temperature	T <sub>j</sub> , T <sub>stg</sub>	-55~+175	°C

Note : 1. Pulse width limited by maximum junction temperature  
 2. Duty cycle ≤ 1%

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R <sub>th,j-c</sub>	2.5	°C/W
Thermal Resistance, Junction-to-ambient, max	R <sub>th,j-a</sub>	75	°C/W

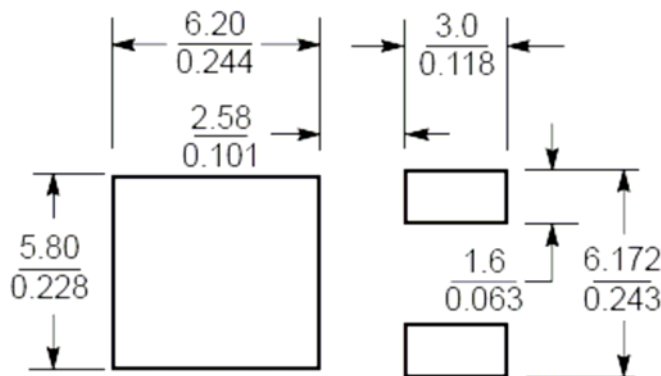
**Characteristics (T<sub>c</sub>=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	100	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	1.5	2.5	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub>	-	38	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =30A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±30
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V
	-	-	25	μA	V <sub>DS</sub> =70V, V <sub>GS</sub> =0V, T <sub>j</sub> =125°C
*R <sub>DS(ON)</sub>	-	22	30	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =30A
*I <sub>D(ON)</sub>	50	-	-	A	V <sub>DS</sub> =10V, V <sub>GS</sub> =10V
<b>Dynamic</b>					
*Q <sub>g</sub>	-	45	-	nC	I <sub>D</sub> =30A, V <sub>DS</sub> =80V, V <sub>GS</sub> =10V
*Q <sub>gs</sub>	-	15	-		
*Q <sub>gd</sub>	-	25	-		
*t <sub>d(ON)</sub>	-	25	-	ns	V <sub>DS</sub> =50V, I <sub>D</sub> =1A, V <sub>GS</sub> =10V, R <sub>G</sub> =6Ω
*t <sub>r</sub>	-	200	-		
*t <sub>d(OFF)</sub>	-	100	-		
*t <sub>f</sub>	-	120	-		

Ciss	-	9600	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz
Coss	-	275	-		
Crss	-	197	-		
Rg	-	2	-	Ω	V <sub>GS</sub> =15mV, V <sub>DS</sub> =0V, f=1MHz
<b>Source-Drain Diode</b>					
*I <sub>S</sub>	-	-	50	A	
*I <sub>SM</sub>	-	-	150		
*V <sub>SD</sub>	-	-	1.3	V	I <sub>F</sub> =I <sub>S</sub> , V <sub>GS</sub> =0V
*trr	-	120	-	ns	I <sub>F</sub> =25A, V <sub>GS</sub> =0, dI/dt=100A/μs
*Qrr	-	380	-	nC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

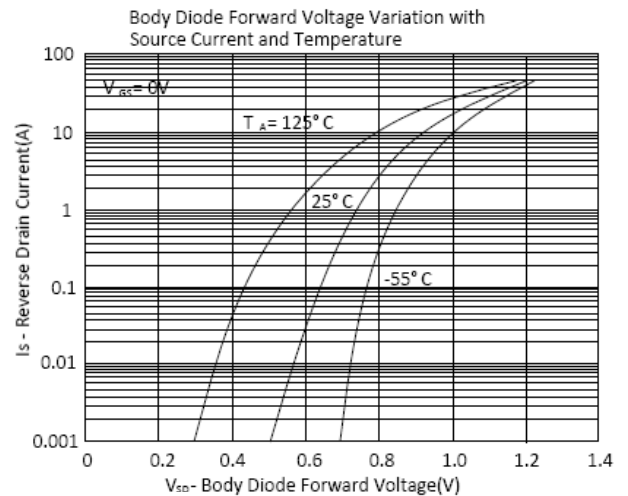
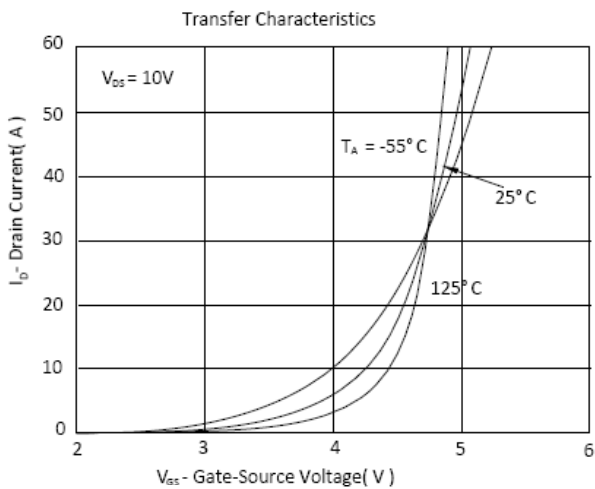
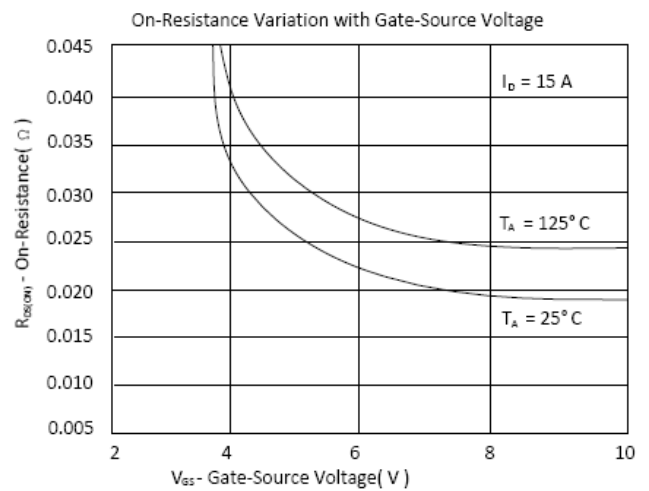
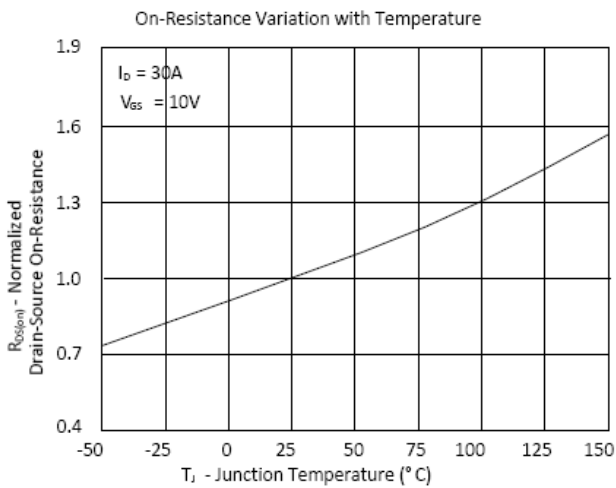
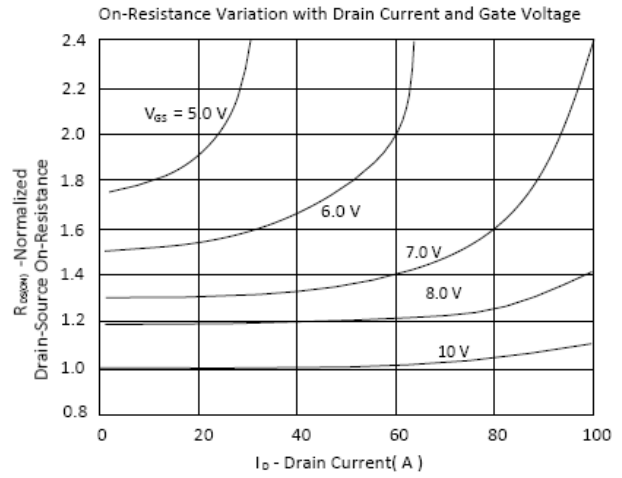
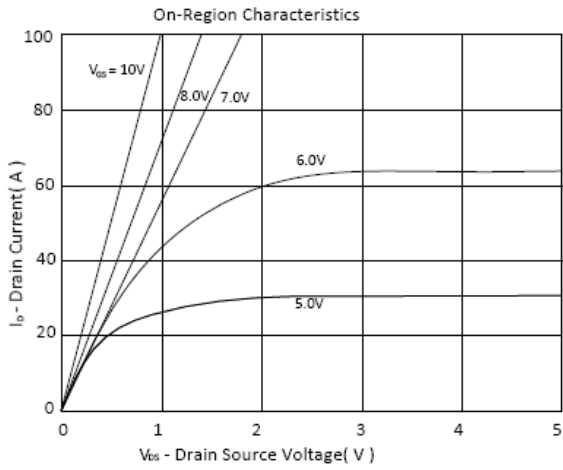
**Recommended soldering footprint**



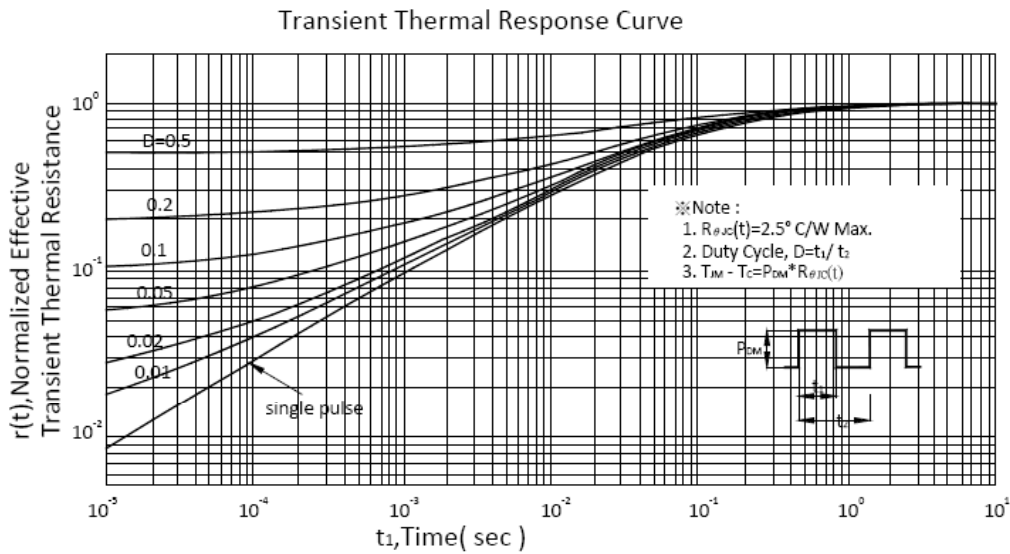
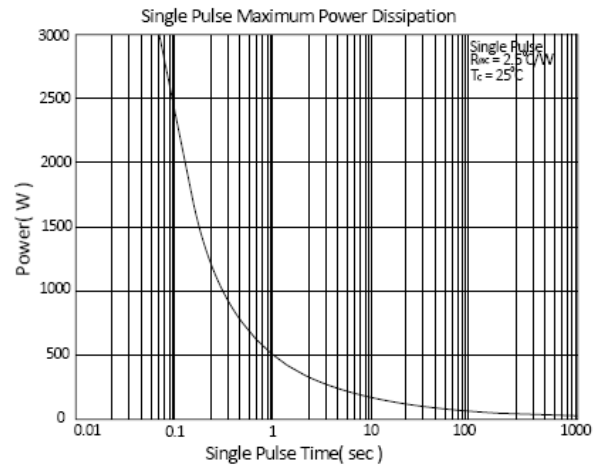
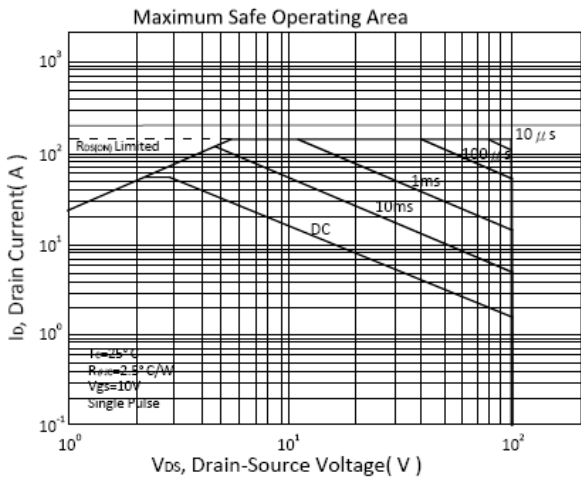
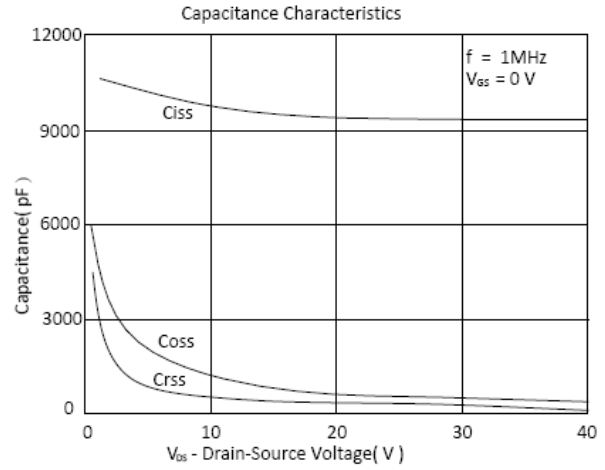
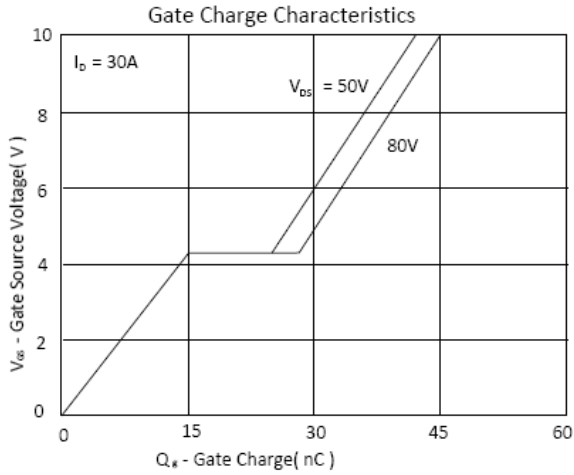
Unit (  $\frac{\text{mm}}{\text{inch}}$  )



## Characteristic Curves



## Characteristic Curves(Cont.)

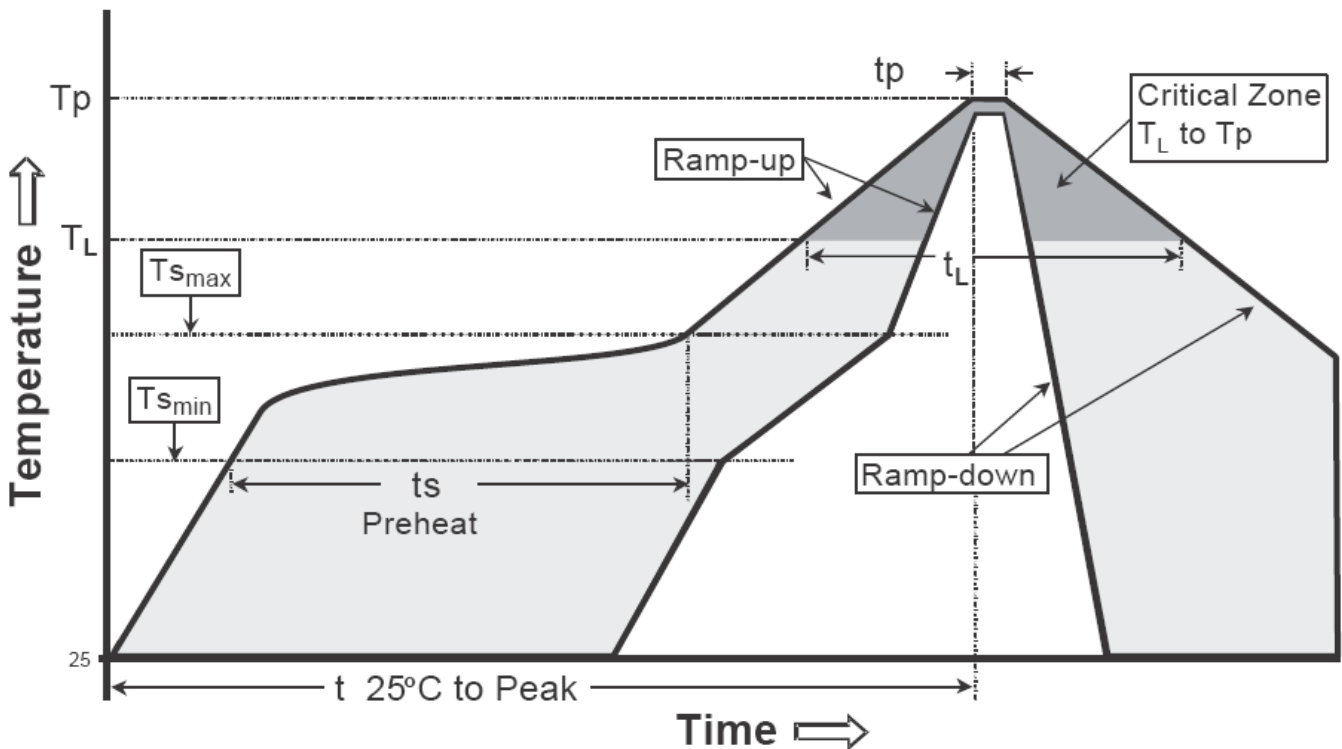




**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

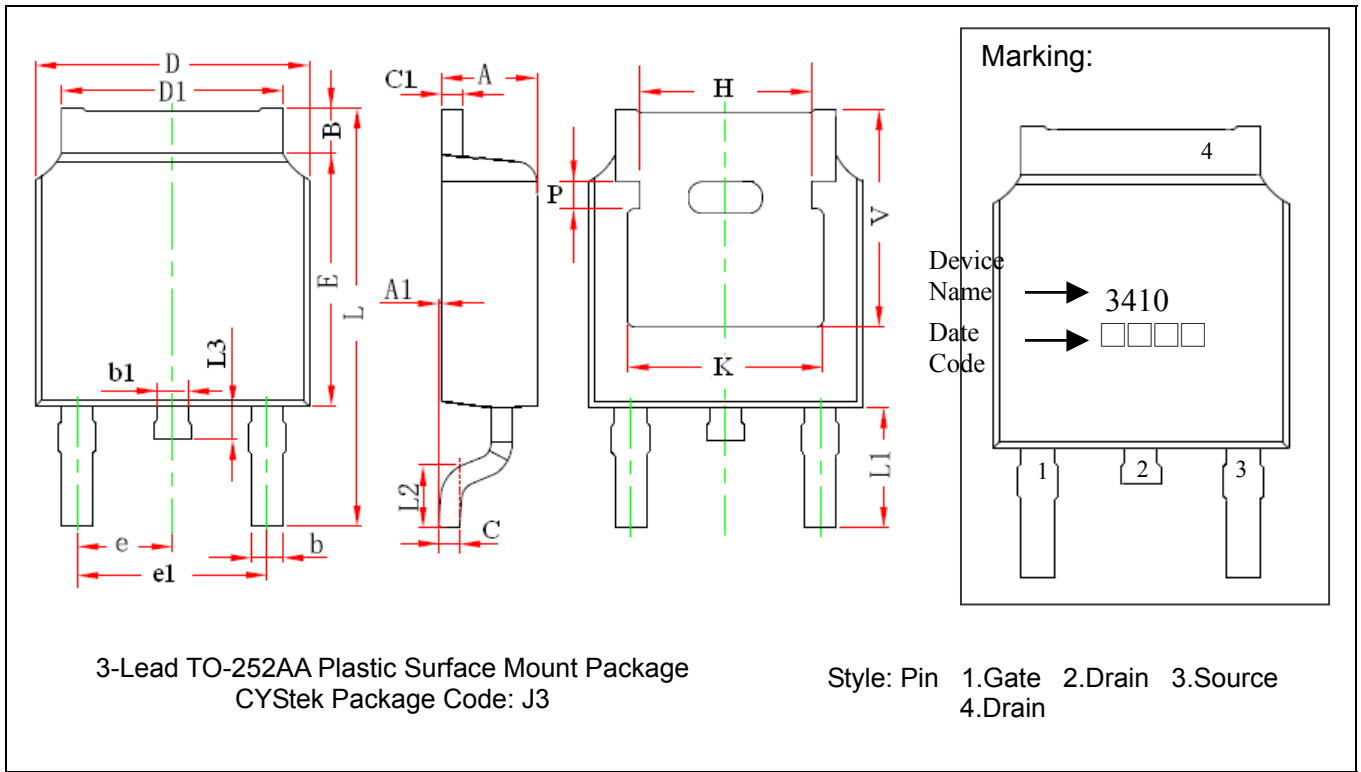
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>P</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**TO-252AA Dimension**



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	e	0.086	0.094	2.186	2.386
A1	0.000	0.005	0.000	0.127	e1	0.172	0.188	4.372	4.772
B	0.039	0.048	0.990	1.210	H	0.163	REF	4.140	REF
b	0.026	0.034	0.660	0.860	K	0.190	REF	4.830	REF
b1	0.026	0.034	0.660	0.860	L	0.386	0.409	9.800	10.400
C	0.018	0.023	0.460	0.580	L1	0.114	REF	2.900	REF
C1	0.018	0.023	0.460	0.580	L2	0.055	0.067	1.400	1.700
D	0.256	0.264	6.500	6.700	L3	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	P	0.026	REF	0.650	REF
E	0.236	0.244	6.000	6.200	V	0.211	REF	5.350	REF

- Notes:**
- Controlling dimension: millimeters.
  - Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
  - If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead : Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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